STW14NM50

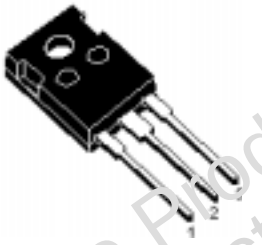
N-CHANNEL 550V @ Tjmax - 0.32Ω - 14A TO-247
MDmesh™ MOSFET

Table 1: General Features

TYPE	V_{DSS} (@Tjmax)	$R_{DS(on)}$	I_D
STW14NM50	550 V	< 0.35 Ω	14 A

- TYPICAL $R_{DS}(on)$ = 0.32 Ω
- HIGH dv/dt AND AVALANCHE CAPABILITIES
- 100% AVALANCHE RATED
- LOW INPUT CAPACITANCE AND GATE CHARGE
- LOW GATE INPUT RESISTANCE
- TIGHT PROCESS CONTROL AND HIGH MANUFACTORING YIELDS

Figure 1: Package

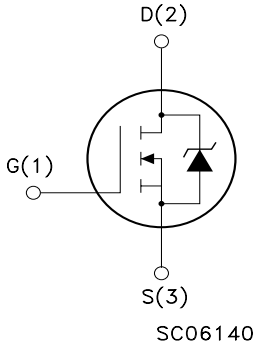


TO-247

DESCRIPTION

The MDmesh™ is a new revolutionary MOSFET technology that associates the Multiple Drain process with the Company's PowerMESH™ horizontal layout. The resulting product has an outstanding low on-resistance, impressively high dv/dt and excellent avalanche characteristics. The adoption of the Company's proprietary strip technique yields overall dynamic performance that is significantly better than that of similar competition's products.

Figure 2: Internal Schematic Diagram



APPLICATIONS

The MDmesh™ family is very suitablr for increase the power density of high voltage converters allowing system miniaturization and higher efficiencies.

Table 2: Order Codes

SALES TYPE	MARKING	PACKAGE	PACKAGING
STW14NM50	W14NM50	TO-247	TUBE

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Table 3: Absolute Maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate- source Voltage	±30	V
I_D	Drain Current (continuous) at T_C = 25°C	14	A
I_D	Drain Current (continuous) at T_C = 100°C	8.8	A
I_{DM} (1)	Drain Current (pulsed)	56	A
P_{TOT}	Total Dissipation at T_C = 25°C	175	W
	Derating Factor	1.28	W/°C
dv/dt	Peak Diode Recovery voltage slope	6	V/ns
T_{stg}	Storage Temperature	–65 to 150	°C
T_j	Max. Operating Junction Temperature	150	°C

(•)Pulse width limited by safe operating area
(*)Limited only by maximum temperature allowed
(1)I_{SD} ≤14A, di/dt ≤100A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_j ≤ T_{JMAX}.

Table 4: Thermal Data

Rthj-case	Thermal Resistance Junction-case Max	0.715	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	50	°C/W
T_l	Maximum Lead Temperature For Soldering Purpose	300	°C

Table 5: Avalanche Characteristics

Symbol	Parameter	Max Value	Unit
I_{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max)	12	A
E_{AS}	Single Pulse Avalanche Energy (starting T_j = 25 °C, I_D = I_{AR}, V_{DD} = 50 V)	400	mJ

ELECTRICAL CHARACTERISTICS (T_{CASE} =25°C UNLESS OTHERWISE SPECIFIED)

Table 6: On /Off

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown Voltage	I_D = 250 µA, V_{GS} = 0	500			V
I_{DSS}	Zero Gate Voltage Drain Current (V_{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating, T_C = 125°C			1 10	µA µA
I_{GSS}	Gate-body Leakage Current (V_{DS} = 0)	V_{GS} = ± 30 V			± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 µA	3	4	5	V
$R_{DS(on}$	Static Drain-source On Resistance	V_{GS} = 10 V, I_D = 6 A		0.32	0.35	Ω

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ELECTRICAL CHARACTERISTICS (CONTINUED)

Table 7: Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g_{fs} (1)	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$, $I_D = 6A$		5.2		S
C_{iss} C_{oss} C_{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25$ V, f = 1 MHz, $V_{GS} = 0$		1000 180 25		pF pF pF
$C_{OSS\ eq}$ (3).	Equivalent Output Capacitance	$V_{GS} = 0$ V, $V_{DS} = 0$ to 400 V		90		pF
R_G	Gate Input Resistance	f=1 MHz Gate DC Bias = 0 Test Signal Level = 20mV Open Drain		1.6		Ω
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	Turn-on Delay Time Rise Time Turn-off-Delay Time Fall Time	$V_{DD} = 250$ V, $I_D = 6$ A, $R_G = 4.7\ \Omega$, $V_{GS} = 10$ V (see Figure 15)		20 10 19 8		ns ns ns ns
Q_g Q_{gs} Q_{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 400$ V, $I_D = 12$ A, $V_{GS} = 10$ V (see Figure 18)		28 8 15	38	nC nC nC

Table 8: Source Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD} I_{SDM} (2)	Source-drain Current Source-drain Current (pulsed)				14 56	A A
V_{SD} (1)	Forward On Voltage	$I_{SD} = 12$ A, $V_{GS} = 0$			1.5	V
t_{rr} Q_{rr} I_{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 12$ A, di/dt = 100 A/µs $V_{DD} = 100$V (see Figure 16)		270 2.23 16.5		ns µC A
t_{rr} Q_{rr} I_{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 12$ A, di/dt = 100 A/µs $V_{DD} = 100$V, $T_j = 150$°C (see Figure 16)		340 3 18		ns µC A

(1) Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %.
(2) Pulse width limited by safe operating area.
(3) $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.

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Figure 3: Safe Operating Area

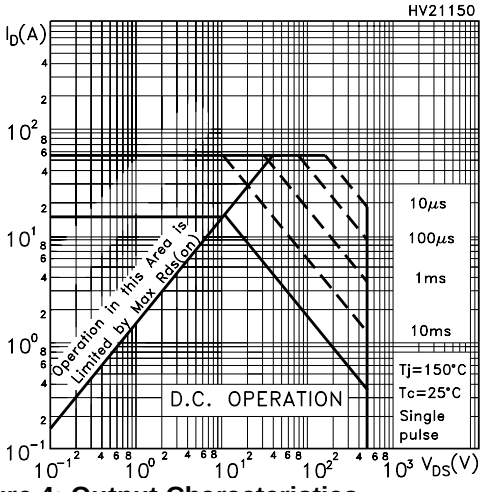

Figure 4: Output Characteristics

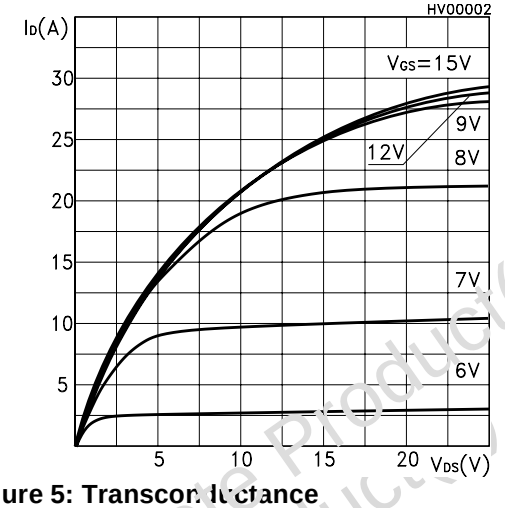

Figure 5: Transconductance

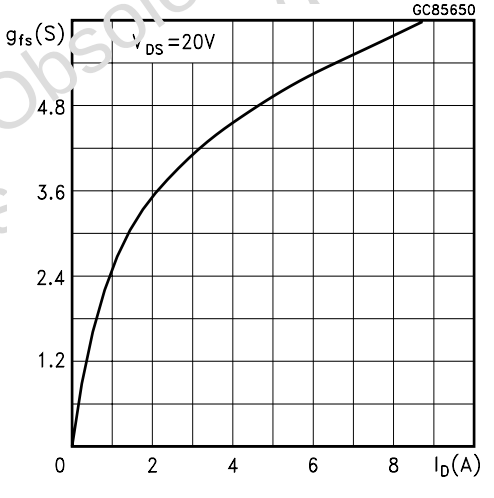

Figure 6: Thermal Impedance

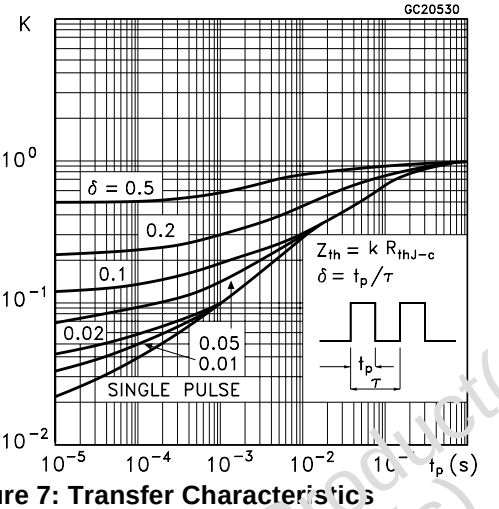

Figure 7: Transfer Characteristics

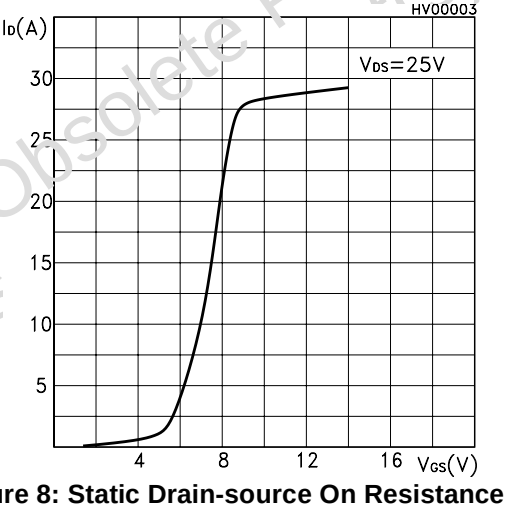

Figure 8: Static Drain-source On Resistance

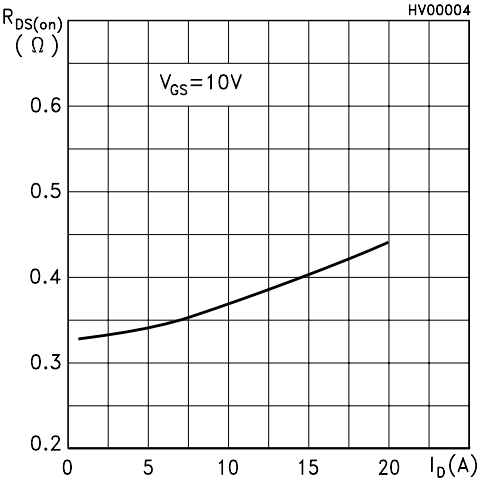

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Figure 9: Gate Charge vs Gate-source Voltage

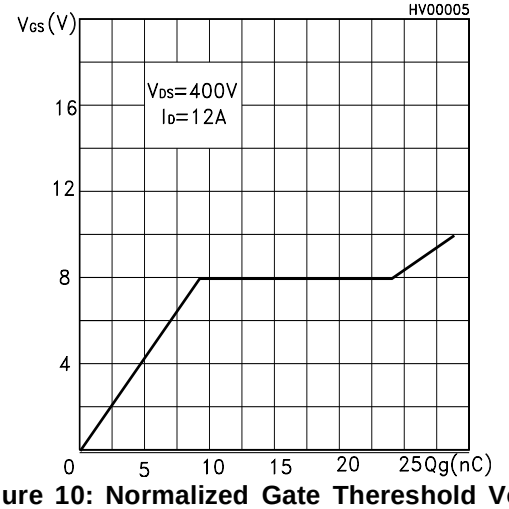

Figure 10: Normalized Gate Thereshold Voltage vs Temperature

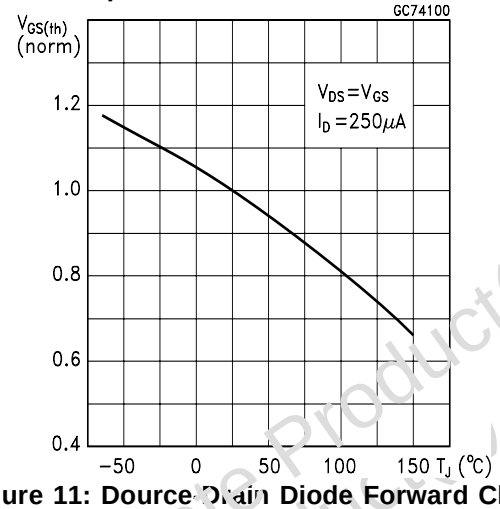

Figure 11: Dource Drain Diode Forward Characteristics

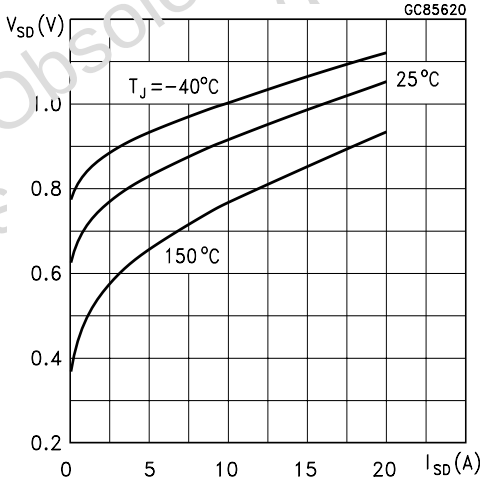

Figure 12: Capacitance Variations

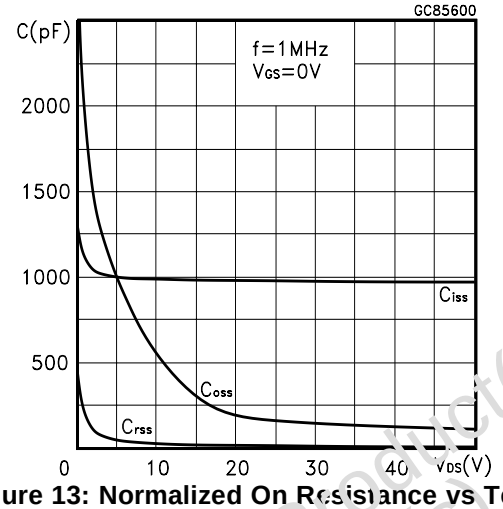

Figure 13: Normalized On Resistance vs Temperature

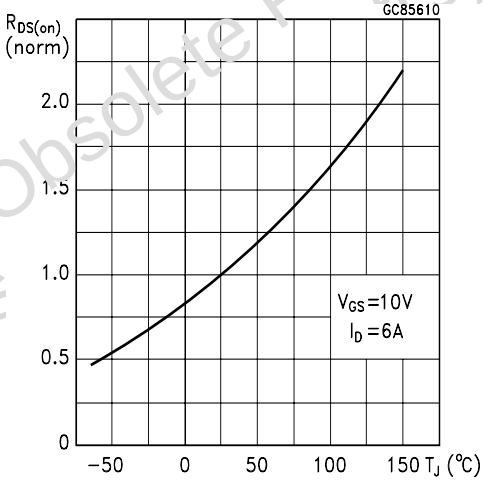

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Figure 14: Unclamped Inductive Load Test Circuit

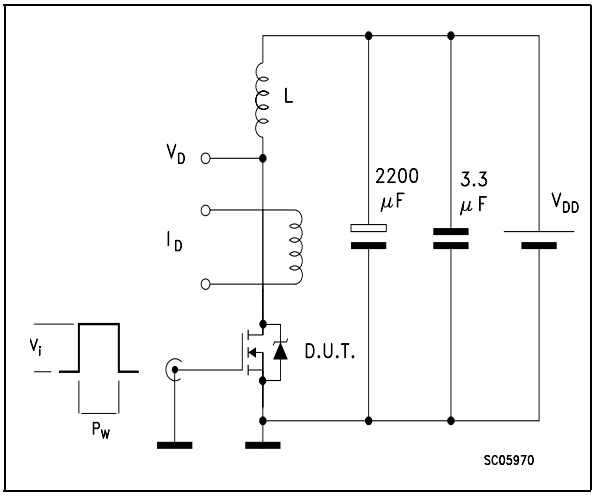


Figure 15: Switching Times Test Circuit For Resistive Load

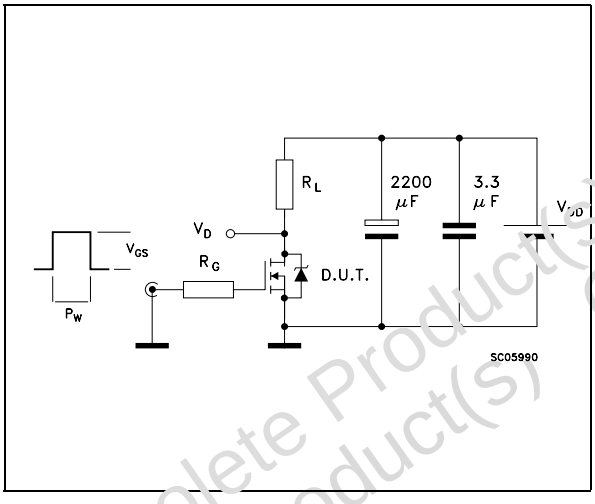


Figure 16: Test Circuit For Inductive Load Switching and Diode Recovery Times

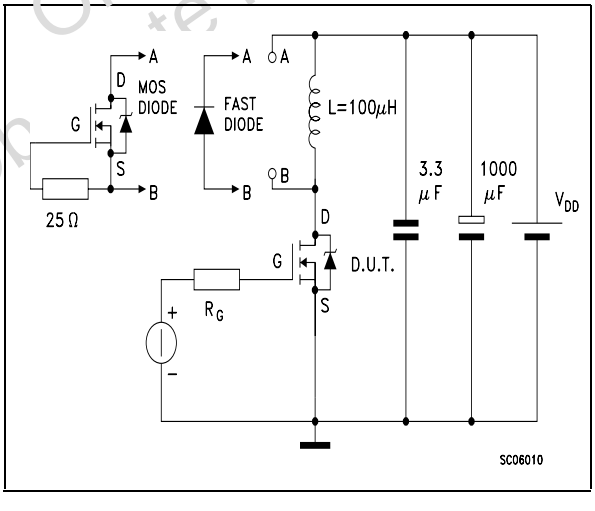


Figure 17: Unclamped Inductive Wafeform

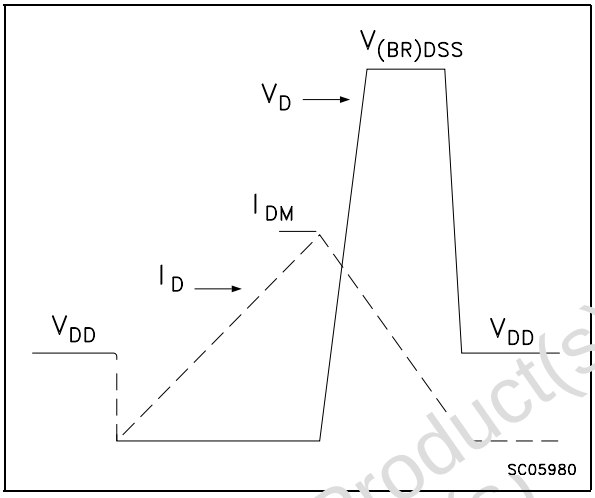
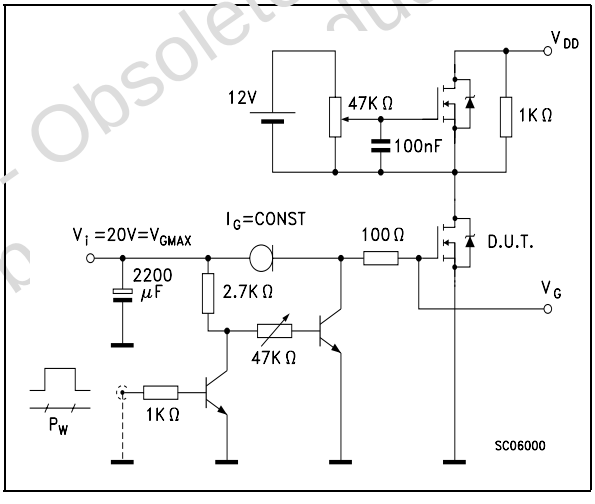


Figure 18: Gate Charge Test Circuit



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TO-247 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
c	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
e		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øP	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	

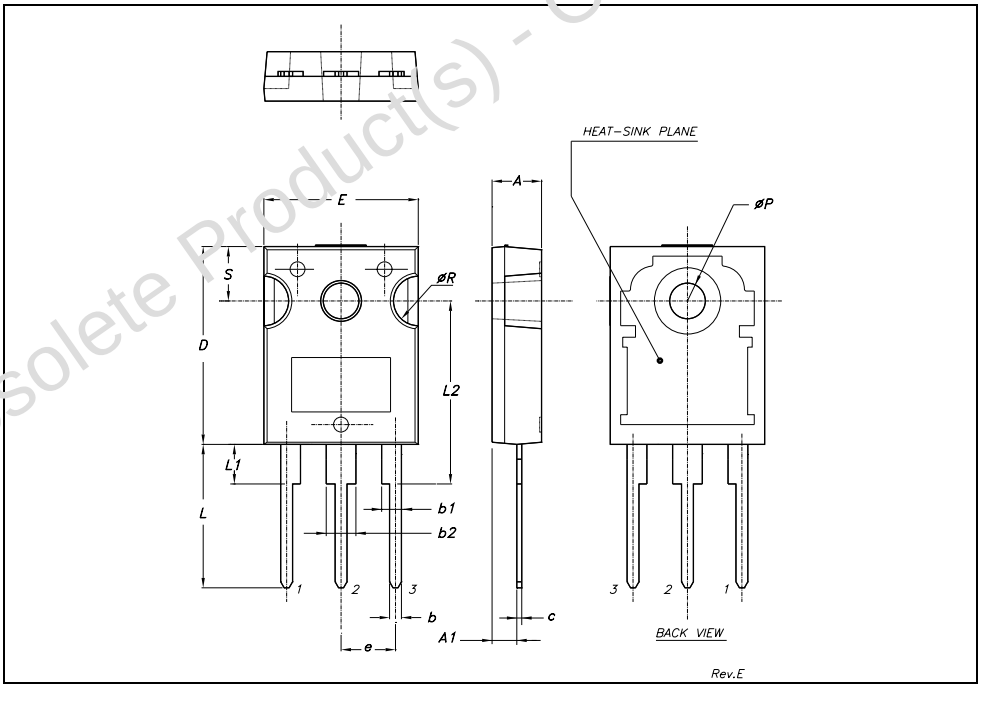

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Table 9: Revision History

Date	Revision	Description of Changes
05-July-2004	5	The document change from “PRELIMINARY” to “COMPLETE”. New Stylesheet.

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